

Contents

	Foreword
	Introduction
1	Scope
2	Normative references
3	Terms and definitions
4	Optical sensing using semiconductor lasers
4.1	General
4.2	Semiconductor laser
4.2.1	General
4.2.2	Basic structure
4.2.3	Transverse mode stabilizing structure
4.2.4	Mode (wavelength) selection structure
4.2.5	Active layer structure
4.3	Common sensing technique and equipment using semiconductor lasers
4.3.1	General
4.3.2	Tunable laser absorption spectroscopy (TLAS)
4.3.3	Cavity ring down spectroscopy (CRDS)
4.3.4	Photoacoustic spectroscopy (PAS)
4.4	Temperature and current dependence of wavelength
4.5	Effect of current injection on lasing wavelength
4.6	Effect of ambient temperature on lasing wavelength
5	Measurement method for temperature dependence of wavelength
5.1	General
5.2	Description of measurement setup and requirements
5.3	Precautions to be observed
5.4	Measurement procedures
6	Measurement method for current dependence of wavelength
6.1	General
6.2	Description of measurement setup and requirements
6.3	Precautions to be observed
6.4	Measurement procedures
6.4.1	Static current dependence
6.4.2	Dynamic current coefficient
7	Measurement method of spectral line width
7.1	General
7.2	Description of measurement setup and requirements
7.3	Precautions to be observed
7.4	Measurement procedures
7.4.1	System employing two semiconductor lasers [shown in Figures 11 and 12]
7.4.2	Self-delayed heterodyne [shown in Figure 13]
Annex A	(informative) Essential ratings and characteristics
A.1	General
A.2	Symbols (and abbreviated terms)
A.3	Essential ratings and characteristics of TO can laser devices

- A.3.1 Type
- A.3.2 Semiconductor material
- A.3.3 Structure
- A.3.4 Details of outline and encapsulation
- A.3.5 Limiting values (absolute maximum system) over the operating temperature range, unless otherwise stated
- A.3.6 Electrical and optical characteristics
- A.3.7 Hazard
- A.4 Essential ratings and characteristics of modules with pigtail fibre
- A.4.1 Type
- A.4.2 Semiconductor material
- A.4.3 Structure
- A.4.4 Details of outline and encapsulation
- A.4.5 Limiting values (absolute maximum system) over the operating temperature range, unless otherwise stated
- A.4.6 Electrical and optical characteristics
- A.4.7 Hazard

Page count: 29